

Notice of References Cited	Application/Control No. 10/676,922	Applicant(s)/Patent Under Reexamination LOWELL, DAVID E.	
	Examiner Eric C. Wai	Art Unit 2195	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,075,938	06-2000	Bugnion et al.	703/27
*	B	US-2002/0083110	06-2002	Kozuch et al.	709/1
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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